

<b>Notice of References Cited</b>		Application/Control No.	Applicant(s)/Patent Under Reexamination MARUYAMA ET AL.	
		Examiner Sin J. Lee	Art Unit 1752	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,869,744 B2	03-2005	Hatakeyama, Jun	430/270.1
	B	US-2001/0035394 A1	11-2001	Takeda et al.	216/41
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

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	X	

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